

TYPES TIS94 THRU TIS99

N-P-N SILICON TRANSISTORS

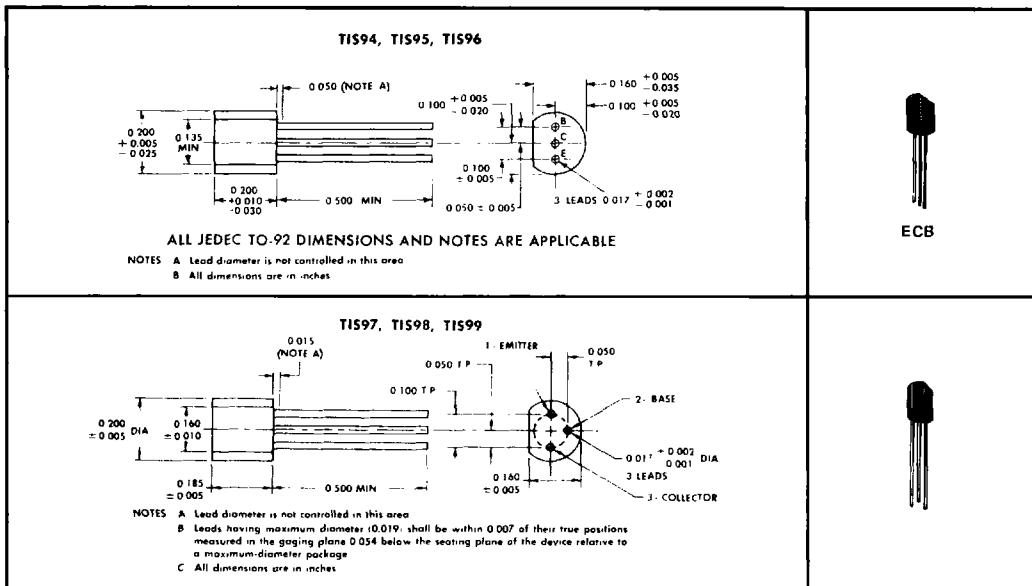
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A COMPLETE FAMILY OF LOW-NOISE, LOW- TO MEDIUM-CURRENT SILECT[†] TRANSISTORS[‡] FOR USE IN HI-FI AUDIO AMPLIFIERS AND GENERAL PURPOSE LOW-FREQUENCY APPLICATIONS

- High $V(BR)CEO$. . . 65 V Min (TIS96 and TIS99)
- Excellent hFE Linearity to 100 mA

mechanical data

These transistors are encapsulated in a plastic compound specifically designed for this purpose, using a highly mechanized process developed by Texas Instruments. The case will withstand soldering temperatures without deformation. These devices exhibit stable characteristics under high-humidity conditions and are capable of meeting MIL-STD-202C, Method 106B. The transistors are insensitive to light.



absolute maximum ratings at 25°C free-air temperature (unless otherwise noted)

	TIS94	TIS95	TIS96
	TIS97	TIS98	TIS99
Collector-Base Voltage	60 V	80 V	80 V
Collector-Emitter Voltage (See Note 1)	40 V	60 V	65 V
Emitter-Base Voltage	6 V	6 V	6 V
Continuous Collector Current	200 mA		
Continuous Device Dissipation at (or below) 25°C Free-Air Temperature (See Note 2)	625 mW		
Continuous Device Dissipation at (or below) 25°C Lead Temperature (See Note 3)	1.25 W		
Storage Temperature Range	-65°C to 150°C		
Lead Temperature 1/16 Inch from Case for 10 Seconds	260°C		

NOTES: 1. These values apply between 0 and 10 mA collector current when the base-emitter diode is open-circuited.
2. Derate linearly to 150°C free-air temperature at the rate of 5 mW/°C.
3. Derate linearly to 150°C lead temperature at the rate of 10 mW/°C. Lead temperature is measured on the collector lead 1/16 inch from the case.

[†]Trademark of Texas Instruments
[‡]U.S. Patent No. 3,439,238

USES CHIP N21

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electrical characteristics at 25°C free-air temperature

PARAMETER	TEST CONDITIONS	TIS94 TIS97			TIS95 TIS98			TIS96 TIS99			UNIT
		MIN	Typ	MAX	MIN	Typ	MAX	MIN	Typ	MAX	
$V_{(BR)CEO}$	Collector-Emitter Breakdown Voltage $I_C = 10 \text{ mA}, I_E = 0$, See Note 4	40			60			65			V
I_{CBO}	Collector Cutoff Current $V_{CB} = 40 \text{ V}, I_E = 0$			10			10			10	nA
I_{CEO}	Emitter Cutoff Current $V_{CB} = 60 \text{ V}, I_E = 0$				10						μA
I_{CEO}	Emitter Cutoff Current $V_{CB} = 80 \text{ V}, I_E = 0$						10			10	μA
V_{CE}	Collector-Emitter Voltage $V_{CE} = 5 \text{ V}, I_C = 100 \mu\text{A}$			20			20			20	nA
h_{FE}	Static Forward Current Transfer Ratio ^S $V_{CE} = 5 \text{ V}, I_C = 1 \text{ mA}$				100	200	300				
V_{BE}	Base-Emitter Voltage $V_{CE} = 5 \text{ V}, I_C = 1 \text{ mA}$							60	125		
V_{BE}	Base-Emitter Voltage $V_{CE} = 5 \text{ V}, I_C = 10 \text{ mA}$, See Note 4							55	110	300	
V_{CE}	Collector-Emitter Voltage $I_B = 0.1 \text{ mA}, I_C = 10 \text{ mA}$, See Note 4				0.45	0.65					V
V_{CE}	Collector-Emitter Voltage $I_B = 2 \text{ mA}, I_C = 100 \text{ mA}$, See Note 4						0.5	0.7			V
$V_{CE(sat)}$	Collector-Emitter Saturation Voltage $I_B = 5 \text{ mA}, I_C = 100 \text{ mA}$, See Note 4						1				V
h_{ie}	Small-Signal Common-Emitter Input Impedance $V_{CE} = 5 \text{ V}, I_C = 100 \mu\text{A}$				115						kΩ
h_{fe}	Small-Signal Common-Emitter Forward Current Transfer Ratio $V_{CE} = 5 \text{ V}, I_C = 1 \text{ mA}$					6.4					
h_{re}	Small-Signal Common-Emitter Reverse Voltage Transfer Ratio $V_{CE} = 5 \text{ V}, I_C = 10 \text{ mA}$						0.5				
h_{oe}	Small-Signal Common-Emitter Output Admittance $V_{CE} = 5 \text{ V}, I_C = 100 \mu\text{A}$				250	440	800				μmho
Y_{fe}	Small-Signal Common-Emitter Forward Transfer Admittance $V_{CE} = 5 \text{ V}, I_C = 1 \text{ mA}$					100	240	400			
$ h_{fe} $	Small-Signal Common-Emitter Forward Current Transfer Ratio $V_{CE} = 5 \text{ V}, I_C = 10 \text{ mA}$						60	130	500		
C_{cb}	Collector-Base Capacitance $V_{CB} = 5 \text{ V}, I_E = 0$, f = 1 MHz, See Note 5				30x 10 ⁻¹²						
C_{eb}	Emitter-Base Capacitance $V_{EB} = 0.5 \text{ V}, I_C = 0$, f = 1 MHz, See Note 5					1.5x 10 ⁻¹²					
							0.9x 10 ⁻¹²				

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operating characteristics at 25°C free-air temperature

PARAMETER	TEST CONDITIONS	TIS94, TIS97			UNIT
		MAX			
F	Spot Noise Figure $V_{CE} = 5 \text{ V}, I_C = 30 \mu\text{A}$, f = 1 kHz, Noise Bandwidth = 100 Hz			2	dB
F	Average Noise Figure $V_{CE} = 5 \text{ V}, I_C = 100 \mu\text{A}$, Noise Bandwidth = 15.7 kHz, See Note 6			3	dB

- NOTES: 4. These parameters must be measured using pulse techniques. $t_{PW} = 300 \mu\text{s}$, duty cycle $\leq 2\%$.
 5. C_{cb} and C_{eb} are measured using three-terminal measurement techniques with the third electrode (emitter or collector, respectively) guarded.
 6. Average Noise Figure is measured in an amplifier with response down 3 dB at 10 Hz and 10 kHz and a high-frequency rolloff of 6 dB/octave.

^SThe TIS96 and TIS99 are color-coded on h_{FE} measured at $V_{CE} = 5 \text{ V}, I_C = 100 \text{ mA}$. Each h_{FE} bracket has a 2-to-1 spread as follows: red, 55-110; orange, 90-180; yellow, 150-300. No particular h_{FE} distribution is implied by this coding system.